# E·XFL

### Intel - EP20K100BC356-2N Datasheet



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#### Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

D	e	ta	i	ls

Details	
Product Status	Obsolete
Number of LABs/CLBs	416
Number of Logic Elements/Cells	4160
Total RAM Bits	53248
Number of I/O	252
Number of Gates	263000
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	356-LBGA
Supplier Device Package	356-BGA (35x35)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep20k100bc356-2n

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APEX 20K devices provide two dedicated clock pins and four dedicated input pins that drive register control inputs. These signals ensure efficient distribution of high-speed, low-skew control signals. These signals use dedicated routing channels to provide short delays and low skews. Four of the dedicated inputs drive four global signals. These four global signals can also be driven by internal logic, providing an ideal solution for a clock divider or internally generated asynchronous clear signals with high fan-out. The dedicated clock pins featured on the APEX 20K devices can also feed logic. The devices also feature ClockLock and ClockBoost clock management circuitry. APEX 20KE devices provide two additional dedicated clock pins, for a total of four dedicated clock pins.

#### **MegaLAB Structure**

APEX 20K devices are constructed from a series of MegaLAB<sup>TM</sup> structures. Each MegaLAB structure contains a group of logic array blocks (LABs), one ESB, and a MegaLAB interconnect, which routes signals within the MegaLAB structure. The EP20K30E device has 10 LABs, EP20K60E through EP20K600E devices have 16 LABs, and the EP20K1000E and EP20K1500E devices have 24 LABs. Signals are routed between MegaLAB structures and I/O pins via the FastTrack Interconnect. In addition, edge LABs can be driven by I/O pins through the local interconnect. Figure 2 shows the MegaLAB structure.







Figure 6. APEX 20K Carry Chain





A row line can be driven directly by LEs, IOEs, or ESBs in that row. Further, a column line can drive a row line, allowing an LE, IOE, or ESB to drive elements in a different row via the column and row interconnect. The row interconnect drives the MegaLAB interconnect to drive LEs, IOEs, or ESBs in a particular MegaLAB structure.

A column line can be directly driven by LEs, IOEs, or ESBs in that column. A column line on a device's left or right edge can also be driven by row IOEs. The column line is used to route signals from one row to another. A column line can drive a row line; it can also drive the MegaLAB interconnect directly, allowing faster connections between rows.

Figure 10 shows how the FastTrack Interconnect uses the local interconnect to drive LEs within MegaLAB structures.

Figure 11 shows the intersection of a row and column interconnect, and how these forms of interconnects and LEs drive each other.



Figure 11. Driving the FastTrack Interconnect

APEX 20KE devices include an enhanced interconnect structure for faster routing of input signals with high fan-out. Column I/O pins can drive the FastRow<sup>™</sup> interconnect, which routes signals directly into the local interconnect without having to drive through the MegaLAB interconnect. FastRow lines traverse two MegaLAB structures. Also, these pins can drive the local interconnect directly for fast setup times. On EP20K300E and larger devices, the FastRow interconnect drives the two MegaLABs in the top left corner, the two MegaLABs in the top right corner, the two MegaLABS in the bottom left corner, and the two MegaLABs in the bottom right corner. On EP20K200E and smaller devices, FastRow interconnect drives the two MegaLABs on the top and the two MegaLABs on the bottom of the device. On all devices, the FastRow interconnect drives all local interconnect in the appropriate MegaLABs except the local interconnect on the side of the MegaLAB opposite the ESB. Pins using the FastRow interconnect achieve a faster set-up time, as the signal does not need to use a MegaLAB interconnect line to reach the destination LE. Figure 12 shows the FastRow interconnect.



Figure 18. Deep Memory Block Implemented with Multiple ESBs

The ESB implements two forms of dual-port memory: read/write clock mode and input/output clock mode. The ESB can also be used for bidirectional, dual-port memory applications in which two ports read or write simultaneously. To implement this type of dual-port memory, two or four ESBs are used to support two simultaneous reads or writes. This functionality is shown in Figure 19.



#### Figure 26. APEX 20KE Bidirectional I/O Registers N





#### Notes to Figure 26:

- (1) This programmable delay has four settings: off and three levels of delay.
- (2) The output enable and input registers are LE registers in the LAB adjacent to the bidirectional pin.

APEX 20KE devices also support the MultiVolt I/O interface feature. The APEX 20KE VCCINT pins must always be connected to a 1.8-V power supply. With a 1.8-V V<sub>CCINT</sub> level, input pins are 1.8-V, 2.5-V, and 3.3-V tolerant. The VCCIO pins can be connected to either a 1.8-V, 2.5-V, or 3.3-V power supply, depending on the I/O standard requirements. When the VCCIO pins are connected to a 1.8-V power supply, the output levels are compatible with 1.8-V systems. When VCCIO pins are connected to a 2.5-V power supply, the output levels are compatible with 2.5-V systems. When VCCIO pins are connected to a 3.3-V power supply, the output levels are sometime with 2.5-V systems. When VCCIO pins are connected to a 3.3-V power supply, the output high is 3.3 V and compatible with 3.3-V or 5.0-V systems. An APEX 20KE device is 5.0-V tolerant with the addition of a resistor.

#### Table 13 summarizes APEX 20KE MultiVolt I/O support.

Table 13. APEX 20KE MultiVolt I/O Support Note (1)									
V <sub>CCIO</sub> (V)		Input Siç	jnals (V)			Output S	ignals (V)		
	1.8	2.5	3.3	5.0	1.8	2.5	3.3	5.0	
1.8	$\checkmark$	$\checkmark$	$\checkmark$		$\checkmark$				
2.5	$\checkmark$	$\checkmark$	<b>&gt;</b>			$\checkmark$			
3.3	$\checkmark$	$\checkmark$	$\checkmark$	(2)			<ul><li>✓(3)</li></ul>		

#### Notes to Table 13:

 The PCI clamping diode must be disabled to drive an input with voltages higher than V<sub>CCIO</sub>, except for the 5.0-V input case.

(2) An APEX 20KE device can be made 5.0-V tolerant with the addition of an external resistor. You also need a PCI clamp and series resistor.

(3) When V<sub>CCIO</sub> = 3.3 V, an APEX 20KE device can drive a 2.5-V device with 3.3-V tolerant inputs.

# ClockLock & ClockBoost Features

APEX 20K devices support the ClockLock and ClockBoost clock management features, which are implemented with PLLs. The ClockLock circuitry uses a synchronizing PLL that reduces the clock delay and skew within a device. This reduction minimizes clock-to-output and setup times while maintaining zero hold times. The ClockBoost circuitry, which provides a clock multiplier, allows the designer to enhance device area efficiency by sharing resources within the device. The ClockBoost circuitry allows the designer to distribute a low-speed clock and multiply that clock on-device. APEX 20K devices include a high-speed clock tree; unlike ASICs, the user does not have to design and optimize the clock tree. The ClockLock and ClockBoost features work in conjunction with the APEX 20K device's high-speed clock to provide significant improvements in system performance and band-width. Devices with an X-suffix on the ordering code include the ClockLock circuit.

The ClockLock and ClockBoost features in APEX 20K devices are enabled through the Quartus II software. External devices are not required to use these features.

For designs that require both a multiplied and non-multiplied clock, the clock trace on the board can be connected to CLK2p. Table 14 shows the combinations supported by the ClockLock and ClockBoost circuitry. The CLK2p pin can feed both the ClockLock and ClockBoost circuitry in the APEX 20K device. However, when both circuits are used, the other clock pin (CLK1p) cannot be used.

Table 14. Multiplication Factor Combinations					
Clock 1	Clock 2				
×1	×1				
×1, ×2	×2				
×1, ×2, ×4	×4				

#### APEX 20KE ClockLock Feature

APEX 20KE devices include an enhanced ClockLock feature set. These devices include up to four PLLs, which can be used independently. Two PLLs are designed for either general-purpose use or LVDS use (on devices that support LVDS I/O pins). The remaining two PLLs are designed for general-purpose use. The EP20K200E and smaller devices have two PLLs; the EP20K300E and larger devices have four PLLs.

The following sections describe some of the features offered by the APEX 20KE PLLs.

#### External PLL Feedback

The ClockLock circuit's output can be driven off-chip to clock other devices in the system; further, the feedback loop of the PLL can be routed off-chip. This feature allows the designer to exercise fine control over the I/O interface between the APEX 20KE device and another high-speed device, such as SDRAM.

#### Clock Multiplication

The APEX 20KE ClockBoost circuit can multiply or divide clocks by a programmable number. The clock can be multiplied by  $m/(n \times k)$  or  $m/(n \times v)$ , where *m* and *k* range from 2 to 160, and *n* and *v* range from 1 to 16. Clock multiplication and division can be used for time-domain multiplexing and other functions, which can reduce design LE requirements.

#### Clock Phase & Delay Adjustment

The APEX 20KE ClockShift feature allows the clock phase and delay to be adjusted. The clock phase can be adjusted by 90° steps. The clock delay can be adjusted to increase or decrease the clock delay by an arbitrary amount, up to one clock period.

#### LVDS Support

Two PLLs are designed to support the LVDS interface. When using LVDS, the I/O clock runs at a slower rate than the data transfer rate. Thus, PLLs are used to multiply the I/O clock internally to capture the LVDS data. For example, an I/O clock may run at 105 MHz to support 840 megabits per second (Mbps) LVDS data transfer. In this example, the PLL multiplies the incoming clock by eight to support the high-speed data transfer. You can use PLLs in EP20K400E and larger devices for high-speed LVDS interfacing.

#### Lock Signals

The APEX 20KE ClockLock circuitry supports individual LOCK signals. The LOCK signal drives high when the ClockLock circuit has locked onto the input clock. The LOCK signals are optional for each ClockLock circuit; when not used, they are I/O pins.

#### ClockLock & ClockBoost Timing Parameters

For the ClockLock and ClockBoost circuitry to function properly, the incoming clock must meet certain requirements. If these specifications are not met, the circuitry may not lock onto the incoming clock, which generates an erroneous clock within the device. The clock generated by the ClockLock and ClockBoost circuitry must also meet certain specifications. If the incoming clock meets these requirements during configuration, the APEX 20K ClockLock and ClockBoost circuitry will lock onto the clock during configuration. The circuit will be ready for use immediately after configuration. In APEX 20KE devices, the clock input standard is programmable, so the PLL cannot respond to the clock until the device is configured. The PLL locks onto the input clock as soon as configuration is complete. Figure 30 shows the incoming and generated clock specifications.

For more information on ClockLock and ClockBoost circuitry, see Application Note 115: Using the ClockLock and ClockBoost PLL Features in APEX Devices. The APEX 20K device instruction register length is 10 bits. The APEX 20K device USERCODE register length is 32 bits. Tables 20 and 21 show the boundary-scan register length and device IDCODE information for APEX 20K devices.

Table 20. APEX 20K Boundary-Scan Register Length						
Device	Boundary-Scan Register Length					
EP20K30E	420					
EP20K60E	624					
EP20K100	786					
EP20K100E	774					
EP20K160E	984					
EP20K200	1,176					
EP20K200E	1,164					
EP20K300E	1,266					
EP20K400	1,536					
EP20K400E	1,506					
EP20K600E	1,806					
EP20K1000E	2,190					
EP20K1500E	1 (1)					

#### Note to Table 20:

(1) This device does not support JTAG boundary scan testing.

Table 2	Table 25. APEX 20K 5.0-V Tolerant Device DC Operating Conditions (Part 2 of 2)   Notes (2), (7), (8)								
Symbol	Parameter	Conditions	Min	Тур	Max	Unit			
V <sub>OL</sub>	3.3-V low-level TTL output voltage	I <sub>OL</sub> = 12 mA DC, V <sub>CCIO</sub> = 3.00 V (11)			0.45	V			
	3.3-V low-level CMOS output voltage	$I_{OL} = 0.1 \text{ mA DC},$ $V_{CCIO} = 3.00 \text{ V} (11)$			0.2	V			
	3.3-V low-level PCI output voltage	I <sub>OL</sub> = 1.5 mA DC, V <sub>CCIO</sub> = 3.00 to 3.60 V (11)			$0.1  imes V_{CCIO}$	V			
	2.5-V low-level output voltage	I <sub>OL</sub> = 0.1 mA DC, V <sub>CCIO</sub> = 2.30 V (11)			0.2	V			
		I <sub>OL</sub> = 1 mA DC, V <sub>CCIO</sub> = 2.30 V (11)			0.4	V			
		I <sub>OL</sub> = 2 mA DC, V <sub>CCIO</sub> = 2.30 V (11)			0.7	V			
I <sub>I</sub>	Input pin leakage current	$V_1 = 5.75$ to $-0.5$ V	-10		10	μA			
I <sub>OZ</sub>	Tri-stated I/O pin leakage current	$V_{O} = 5.75$ to $-0.5$ V	-10		10	μA			
I <sub>CC0</sub>	V <sub>CC</sub> supply current (standby) (All ESBs in power-down mode)	$V_1$ = ground, no load, no toggling inputs, -1 speed grade (12)		10		mA			
		V <sub>1</sub> = ground, no load, no toggling inputs, -2, -3 speed grades (12)		5		mA			
R <sub>CONF</sub>	Value of I/O pin pull-up resistor	V <sub>CCIO</sub> = 3.0 V (13)	20		50	W			
	before and during configuration	V <sub>CCIO</sub> = 2.375 V (13)	30		80	W			



Figure 35 shows the output drive characteristics of APEX 20KE devices.

*Note to Figure 35:*(1) These are transient (AC) currents.

## **Timing Model**

The high-performance FastTrack and MegaLAB interconnect routing resources ensure predictable performance, accurate simulation, and accurate timing analysis. This predictable performance contrasts with that of FPGAs, which use a segmented connection scheme and therefore have unpredictable performance.

All specifications are always representative of worst-case supply voltage and junction temperature conditions. All output-pin-timing specifications are reported for maximum driver strength.

Figure 36 shows the  $f_{MAX}$  timing model for APEX 20K devices.



Figure 37 shows the  $f_{MAX}$  timing model for APEX 20KE devices. These parameters can be used to estimate  $f_{MAX}$  for multiple levels of logic. Quartus II software timing analysis should be used for more accurate timing information.

Table 31. APEX 2	OK f <sub>MAX</sub> Timing Parameters (Part 2 of 2)					
Symbol	Parameter					
t <sub>ESBDATACO2</sub>	ESB clock-to-output delay without output registers					
t <sub>ESBDD</sub>	ESB data-in to data-out delay for RAM mode					
t <sub>PD</sub>	ESB macrocell input to non-registered output					
t <sub>PTERMSU</sub>	ESB macrocell register setup time before clock					
t <sub>PTERMCO</sub>	ESB macrocell register clock-to-output delay					
t <sub>F1-4</sub>	Fanout delay using local interconnect					
t <sub>F5-20</sub>	Fanout delay using MegaLab Interconnect					
t <sub>F20+</sub>	Fanout delay using FastTrack Interconnect					
t <sub>CH</sub>	Minimum clock high time from clock pin					
t <sub>CL</sub>	Minimum clock low time from clock pin					
t <sub>CLRP</sub>	LE clear pulse width					
t <sub>PREP</sub>	LE preset pulse width					
t <sub>ESBCH</sub>	Clock high time					
t <sub>ESBCL</sub>	Clock low time					
t <sub>ESBWP</sub>	Write pulse width					
t <sub>ESBRP</sub>	Read pulse width					

#### Tables 32 and 33 describe APEX 20K external timing parameters.

Table 32. APEX 20K External Timing Parameters   Note (1)					
Symbol	Clock Parameter				
t <sub>INSU</sub>	Setup time with global clock at IOE register				
t <sub>INH</sub>	Hold time with global clock at IOE register				
t <sub>оитсо</sub>	Clock-to-output delay with global clock at IOE register				

Table 33. APEX 20K External Bidirectional Timing Parameters   Note (1)							
Symbol	Parameter	Conditions					
t <sub>INSUBIDIR</sub>	Setup time for bidirectional pins with global clock at same-row or same- column LE register						
t <sub>INHBIDIR</sub>	Hold time for bidirectional pins with global clock at same-row or same-column LE register						
<sup>t</sup> OUTCOBIDIR	Clock-to-output delay for bidirectional pins with global clock at IOE register	C1 = 10 pF					
t <sub>XZBIDIR</sub>	Synchronous IOE output buffer disable delay	C1 = 10 pF					
t <sub>ZXBIDIR</sub>	Synchronous IOE output buffer enable delay, slow slew rate = off	C1 = 10 pF					

Tables 40 through 42 show the  $f_{MAX}$  timing parameters for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

Symbol	-1 Snee	-1 Sneed Grade		d Grade	-3 Sner	-3 Sneed Grade		
oymbol			2 0000		0 0000			
	Min	Max	Min	Max	Min	Max		
t <sub>SU</sub>	0.5		0.6		0.8		ns	
t <sub>H</sub>	0.7		0.8		1.0		ns	
t <sub>CO</sub>		0.3		0.4		0.5	ns	
t <sub>LUT</sub>		0.8		1.0		1.3	ns	
t <sub>ESBRC</sub>		1.7		2.1		2.4	ns	
t <sub>ESBWC</sub>		5.7		6.9		8.1	ns	
t <sub>ESBWESU</sub>	3.3		3.9		4.6		ns	
t <sub>ESBDATASU</sub>	2.2		2.7		3.1		ns	
t <sub>ESBDATAH</sub>	0.6		0.8		0.9		ns	
t <sub>ESBADDRSU</sub>	2.4		2.9		3.3		ns	
t <sub>ESBDATACO1</sub>		1.3		1.6		1.8	ns	
t <sub>ESBDATACO2</sub>		2.6		3.1		3.6	ns	
t <sub>ESBDD</sub>		2.5		3.3		3.6	ns	
t <sub>PD</sub>		2.5		3.0		3.6	ns	
t <sub>PTERMSU</sub>	2.3		2.6		3.2		ns	
t <sub>PTERMCO</sub>		1.5		1.8		2.1	ns	
t <sub>F1-4</sub>		0.5		0.6		0.7	ns	
t <sub>F5-20</sub>		1.6		1.7		1.8	ns	
t <sub>F20+</sub>		2.2		2.2		2.3	ns	
t <sub>CH</sub>	2.0		2.5		3.0		ns	
t <sub>CL</sub>	2.0		2.5		3.0		ns	
t <sub>CLRP</sub>	0.3		0.4		0.4		ns	
t <sub>PREP</sub>	0.5		0.5		0.5		ns	
t <sub>ESBCH</sub>	2.0		2.5		3.0		ns	
t <sub>ESBCL</sub>	2.0		2.5		3.0		ns	
t <sub>ESBWP</sub>	1.6		1.9		2.2		ns	
t <sub>ESBRP</sub>	1.0		1.3		1.4		ns	

Table 46. EP20K200 External Bidirectional Timing Parameters								
Symbol	-1 Spee	d Grade	-2 Spe	-2 Speed Grade		-3 Speed Grade		
	Min	Max	Min	Max	Min	Max		
t <sub>INSUBIDIR</sub> (1)	1.9		2.3		2.6		ns	
t <sub>INHBIDIR</sub> (1)	0.0		0.0		0.0		ns	
t <sub>OUTCOBIDIR</sub> (1)	2.0	4.6	2.0	5.6	2.0	6.8	ns	
t <sub>XZBIDIR</sub> (1)		5.0		5.9		6.9	ns	
t <sub>ZXBIDIR</sub> (1)		5.0		5.9		6.9	ns	
t <sub>INSUBIDIR</sub> (2)	1.1		1.2		-		ns	
t <sub>INHBIDIR</sub> (2)	0.0		0.0		-		ns	
t <sub>OUTCOBIDIR</sub> (2)	0.5	2.7	0.5	3.1	-	-	ns	
t <sub>XZBIDIR</sub> (2)		4.3		5.0		-	ns	
t <sub>ZXBIDIR</sub> (2)		4.3		5.0		-	ns	

### Table 47. EP20K400 External Timing Parameters

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed	Unit			
	Min	Max	Min	Max	Min	Max			
t <sub>INSU</sub> (1)	1.4		1.8		2.0		ns		
t <sub>INH</sub> (1)	0.0		0.0		0.0		ns		
t <sub>OUTCO</sub> (1)	2.0	4.9	2.0	6.1	2.0	7.0	ns		
t <sub>INSU</sub> (2)	0.4		1.0		-		ns		
t <sub>INH</sub> (2)	0.0		0.0		-		ns		
t <sub>OUTCO</sub> (2)	0.5	3.1	0.5	4.1	-	-	ns		

Table 48. EP20K400 External Bidirectional Timing Parameters

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>INSUBIDIR</sub> (1)	1.4		1.8		2.0		ns
t <sub>INHBIDIR</sub> (1)	0.0		0.0		0.0		ns
t <sub>OUTCOBIDIR</sub> (1)	2.0	4.9	2.0	6.1	2.0	7.0	ns
t <sub>XZBIDIR</sub> (1)		7.3		8.9		10.3	ns
t <sub>ZXBIDIR</sub> (1)		7.3		8.9		10.3	ns
t <sub>INSUBIDIR</sub> (2)	0.5		1.0		-		ns
t <sub>INHBIDIR</sub> (2)	0.0		0.0		-		ns
t <sub>OUTCOBIDIR</sub> (2)	0.5	3.1	0.5	4.1	-	-	ns
t <sub>XZBIDIR</sub> (2)		6.2		7.6		-	ns
t <sub>ZXBIDIR</sub> (2)		6.2		7.6		_	ns

#### **Altera Corporation**

Table 50. EP20K30E f <sub>MAX</sub> ESB Timing Microparameters							
Symbol	-1			-2		-3	
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		2.03		2.86		4.24	ns
t <sub>ESBSRC</sub>		2.58		3.49		5.02	ns
t <sub>ESBAWC</sub>		3.88		5.45		8.08	ns
t <sub>ESBSWC</sub>		4.08		5.35		7.48	ns
t <sub>ESBWASU</sub>	1.77		2.49		3.68		ns
t <sub>ESBWAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWDSU</sub>	1.95		2.74		4.05		ns
t <sub>ESBWDH</sub>	0.00		0.00		0.00		ns
t <sub>ESBRASU</sub>	1.96		2.75		4.07		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWESU</sub>	1.80		2.73		4.28		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	0.07		0.48		1.17		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.30		0.80		1.64		ns
t <sub>ESBRADDRSU</sub>	0.37		0.90		1.78		ns
t <sub>ESBDATACO1</sub>		1.11		1.32		1.67	ns
t <sub>ESBDATACO2</sub>		2.65		3.73		5.53	ns
t <sub>ESBDD</sub>		3.88		5.45		8.08	ns
t <sub>PD</sub>		1.91		2.69		3.98	ns
t <sub>PTERMSU</sub>	1.04		1.71		2.82		ns
t <sub>PTERMCO</sub>		1.13		1.34		1.69	ns

# Table 51. EP20K30E f<sub>MAX</sub> Routing Delays

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>F1-4</sub>		0.24		0.27		0.31	ns
t <sub>F5-20</sub>		1.03		1.14		1.30	ns
t <sub>F20+</sub>		1.42		1.54		1.77	ns

Table 68. EP20K160E f <sub>MAX</sub> ESB Timing Microparameters							
Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.65		2.02		2.11	ns
t <sub>ESBSRC</sub>		2.21		2.70		3.11	ns
t <sub>ESBAWC</sub>		3.04		3.79		4.42	ns
t <sub>ESBSWC</sub>		2.81		3.56		4.10	ns
t <sub>ESBWASU</sub>	0.54		0.66		0.73		ns
t <sub>ESBWAH</sub>	0.36		0.45		0.47		ns
t <sub>ESBWDSU</sub>	0.68		0.81		0.94		ns
t <sub>ESBWDH</sub>	0.36		0.45		0.47		ns
t <sub>ESBRASU</sub>	1.58		1.87		2.06		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.01		ns
t <sub>ESBWESU</sub>	1.41		1.71		2.00		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.02		-0.03		0.09		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.14		0.17		0.35		ns
t <sub>ESBRADDRSU</sub>	0.21		0.27		0.43		ns
t <sub>ESBDATACO1</sub>		1.04		1.30		1.46	ns
t <sub>ESBDATACO2</sub>		2.15		2.70		3.16	ns
t <sub>ESBDD</sub>		2.69		3.35		3.97	ns
t <sub>PD</sub>		1.55		1.93		2.29	ns
t <sub>PTERMSU</sub>	1.01		1.23		1.52		ns
t <sub>PTERMCO</sub>		1.06		1.32		1.04	ns

Table 78. EP20K200E External Bidirectional Timing Parameters							
Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>INSUBIDIR</sub>	2.81		3.19		3.54		ns
t <sub>inhbidir</sub>	0.00		0.00		0.00		ns
t <sub>outcobidir</sub>	2.00	5.12	2.00	5.62	2.00	6.11	ns
t <sub>xzbidir</sub>		7.51		8.32		8.67	ns
t <sub>ZXBIDIR</sub>		7.51		8.32		8.67	ns
t <sub>insubidirpll</sub>	3.30		3.64		-		ns
t <sub>inhbidirpll</sub>	0.00		0.00		-		ns
t <sub>outcobidirpll</sub>	0.50	3.01	0.50	3.36	-	-	ns
t <sub>xzbidirpll</sub>		5.40		6.05		-	ns
t <sub>ZXBIDIRPLL</sub>		5.40		6.05		-	ns

Tables 79 through 84 describe  $f_{MAX}$  LE Timing Microparameters,  $f_{MAX}$  ESB Timing Microparameters,  $f_{MAX}$  Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K300E APEX 20KE devices.

Table 79. EP20K300E f <sub>MAX</sub> LE Timing Microparameters							
Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>SU</sub>	0.16		0.17		0.18		ns
t <sub>H</sub>	0.31		0.33		0.38		ns
t <sub>CO</sub>		0.28		0.38		0.51	ns
t <sub>LUT</sub>		0.79		1.07		1.43	ns

SRAM configuration elements allow APEX 20K devices to be reconfigured in-circuit by loading new configuration data into the device. Real-time reconfiguration is performed by forcing the device into command mode with a device pin, loading different configuration data, reinitializing the device, and resuming usermode operation. In-field upgrades can be performed by distributing new configuration files.

#### **Configuration Schemes**

The configuration data for an APEX 20K device can be loaded with one of five configuration schemes (see Table 111), chosen on the basis of the target application. An EPC2 or EPC16 configuration device, intelligent controller, or the JTAG port can be used to control the configuration of an APEX 20K device. When a configuration device is used, the system can configure automatically at system power-up.

Multiple APEX 20K devices can be configured in any of five configuration schemes by connecting the configuration enable (nCE) and configuration enable output (nCEO) pins on each device.

Table 111. Data Sources for Configuration						
Configuration Scheme	Data Source					
Configuration device	EPC1, EPC2, EPC16 configuration devices					
Passive serial (PS)	MasterBlaster or ByteBlasterMV download cable or serial data source					
Passive parallel asynchronous (PPA)	Parallel data source					
Passive parallel synchronous (PPS)	Parallel data source					
JTAG	MasterBlaster or ByteBlasterMV download cable or a microprocessor with a Jam or JBC File					



For more information on configuration, see *Application Note* 116 (*Configuring APEX 20K, FLEX 10K, & FLEX 6000 Devices.*)

# **Device Pin-Outs**

See the Altera web site (http://www.altera.com) or the *Altera Digital Library* for pin-out information